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FDD86540

March 2015

N-Channel PowerTrench[®] MOSFET 60 V, 136 A, 4.1 m Ω

Features

- Max $r_{DS(on)} = 4.1 \text{ m}\Omega$ at $V_{GS} = 10 \text{ V}$, $I_D = 21.5 \text{ A}$
- Max $r_{DS(on)} = 5 \text{ m}\Omega$ at $V_{GS} = 8 \text{ V}$, $I_D = 19.5 \text{ A}$
- 100% UIL tested
- RoHS Compliant

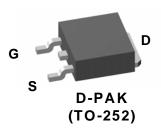
General Description

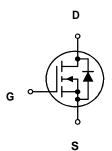
This N-Channel MOSFET has been designed specifically to improve the overall efficiency and to minimize switch node ringing of DC/DC converters using either synchronous or conventional switching PWM controllers.It has been optimized for low gate charge, low $r_{DS(on)}$, fast switching speed and body diode reverse recovery performance.

Applications

- Primary Switch in isolated DC-DC
- Synchronous Rectifier
- Load Switch







MOSFET Maximum Ratings $T_C = 25$ °C unless otherwise noted

Symbol	Paramo	eter		Ratings	Units
V_{DS}	Drain to Source Voltage			60	V
V_{GS}	Gate to Source Voltage			±20	V
	Drain Current -Continuous	T _C = 25 °C	(Note 5)	136	
	-Continuous	T _C = 100 °C	(Note 5)	86	A
ID	-Continuous	T _A = 25 °C	(Note 1a)	21.5	A
	-Pulsed		(Note 4)	240	
E _{AS}	Single Pulse Avalanche Energy		(Note 3)	228	mJ
В	Power Dissipation	T _C = 25 °C		127	W
P_{D}	Power Dissipation	T _A = 25 °C	(Note 1a)	3.1	VV
T _J , T _{STG}	Operating and Storage Junction Tempera	ature Range		-55 to +150	°C

Thermal Characteristics

$R_{\theta JC}$	Thermal Resistance, Junction to Case	0.98	°C/W
$R_{\theta JA}$	Thermal Resistance, Junction to Ambient (Note 1a)	40	C/VV

Package Marking and Ordering Information

Device Marking	Device	Package	Reel Size	Tape Width	Quantity
FDD86540	FDD86540	D-PAK(TO-252)	13 "	16 mm	2500 units

Electrical Characteristics T_J = 25 °C unless otherwise noted

Symbol	Parameter	Test Conditions	Min	Тур	Max	Units			
Off Characteristics									
BV_{DSS}	Drain to Source Breakdown Voltage	$I_D = 250 \mu A, V_{GS} = 0 V$	60			V			
$\frac{\Delta BV_{DSS}}{\Delta T_{J}}$	Breakdown Voltage Temperature Coefficient	I_D = 250 μ A, referenced to 25 °C		28		mV/°C			
I _{DSS}	Zero Gate Voltage Drain Current	V _{DS} = 48 V, V _{GS} = 0 V			1	μΑ			
I _{GSS}	Gate to Source Leakage Current	$V_{GS} = \pm 20 \text{ V}, V_{DS} = 0 \text{ V}$			±100	nA			

On Characteristics

$V_{GS(th)}$	Gate to Source Threshold Voltage	$V_{GS} = V_{DS}, I_{D} = 250 \mu A$	2	3.1	4	V
$\frac{\Delta V_{GS(th)}}{\Delta T_J}$	Gate to Source Threshold Voltage Temperature Coefficient	I_D = 250 μ A, referenced to 25 °C		-11		mV/°C
		V _{GS} = 10 V, I _D = 21.5 A		3.4	4.1	
r _{DS(on)}	Static Drain to Source On Resistance	$V_{GS} = 8 \text{ V}, I_D = 19.5 \text{ A}$		4.1	5	mΩ
, ,		$V_{GS} = 10 \text{ V}, I_D = 21.5 \text{ A}, T_J = 125 \text{ °C}$		5.2	6.3	
g _{FS}	Forward Transconductance	V _{DS} = 10 V, I _D = 21.5 A		75		S

Dynamic Characteristics

C _{iss}	Input Capacitance	V 20 V V 0 V	4767	6340	pF
Coss	Output Capacitance	$V_{DS} = 30 \text{ V}, V_{GS} = 0 \text{ V},$ $f = 1 \text{ MHz}$	1409	1880	pF
C _{rss}	Reverse Transfer Capacitance	1 - 1 1011 12	48	90	pF
R_{α}	Gate Resistance		0.6		Ω

Switching Characteristics

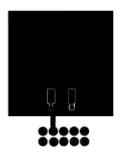
t _{d(on)}	Turn-On Delay Time		26	42	ns
t _r	Rise Time	V _{DD} = 30 V, I _D = 21.5 A,	15	28	ns
t _{d(off)}	Turn-Off Delay Time	$V_{GS} = 10 \text{ V}, R_{GEN} = 6 \Omega$	31	49	ns
t _f	Fall Time		6.9	14	ns
Q_g	Total Gate Charge	V _{GS} = 0 V to 10 V	65	90	nC
Qg	Total Gate Charge	$V_{GS} = 0 \text{ V to 8 V}$ $V_{DD} = 30 \text{ V},$	54	75	nC
Q _{gs}	Gate to Source Charge	I _D = 21.5 A	23		nC
Q _{gd}	Gate to Drain "Miller" Charge		12		nC

Drain-Source Diode Characteristics

V_{SD}	Source-Drain Diode Forward Voltage	$V_{GS} = 0 \text{ V}, I_S = 21.5 \text{ A}$ (Note 2)	8.0	1.3	V
	Jource-Drain Diode Forward Voltage	$V_{GS} = 0 \text{ V}, I_{S} = 2.6 \text{ A}$ (Note 2)	0.7	1.2	V
t _{rr}	Reverse Recovery Time	I _E = 21.5 A, di/dt = 100 A/μs	56	90	ns
Q _{rr}	Reverse Recovery Charge	I _F = 21.5 A, α/αι = 100 Α/μS	43	69	nC

Notes:

^{1:} R_{QJA} is the sum of the junction-to-case and case-to-ambient thermal resistance where the case thermal reference is defined as the solder mounting surface of the drain pins. $R_{\theta JA}$ is determined by the user's board design.



a) 40 °C/W when mounted on a 1 in² pad of 2 oz copper



b) 96 °C/W when mounted on a minimum pad

- Pulse Test: Pulse Width < 300 μs, Duty cycle < 2.0%.
 Starting T_J = 25 °C, L = 0.3 mH, I_{AS} = 39 A, V_{DD} = 54 V, V_{GS} = 10 V.
 Pulsed Id please refer to Fig 11 SOA graph for more details.
 Computed continuous current limited to Max Junction Temperature only, actual continuous current will be limited by thermal & electro-mechanical application board design.

Typical Characteristics T_J = 25 °C unless otherwise noted

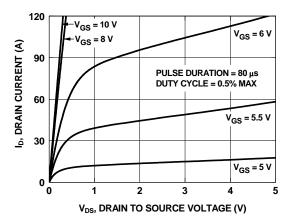


Figure 1. On-Region Characteristics

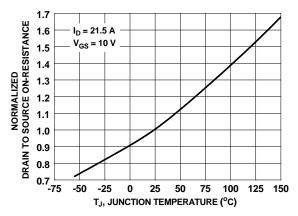


Figure 3. Normalized On-Resistance vs Junction Temperature

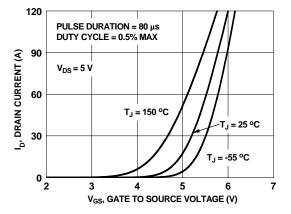


Figure 5. Transfer Characteristics

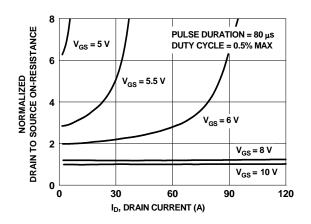


Figure 2. Normalized On-Resistance vs Drain Current and Gate Voltage

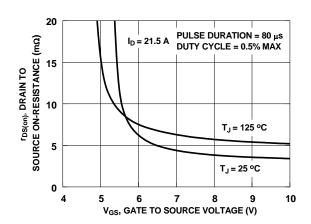


Figure 4. On-Resistance vs Gate to Source Voltage

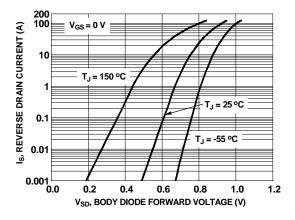


Figure 6. Source to Drain Diode Forward Voltage vs Source Current

Typical Characteristics $T_J = 25$ °C unless otherwise noted

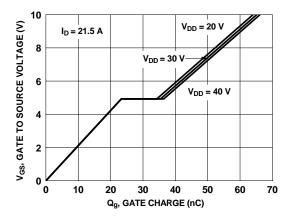


Figure 7. Gate Charge Characteristics

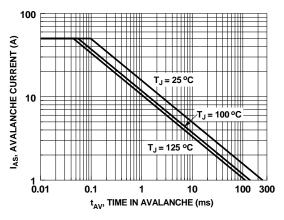


Figure 9. Unclamped Inductive Switching Capability

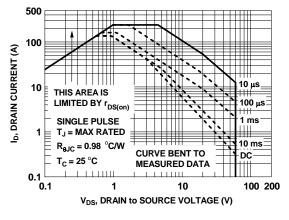


Figure 11. Forward Bias Safe Operating Area

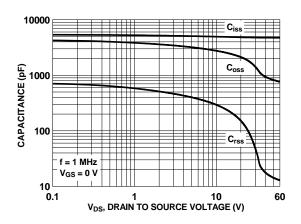


Figure 8. Capacitance vs Drain to Source Voltage

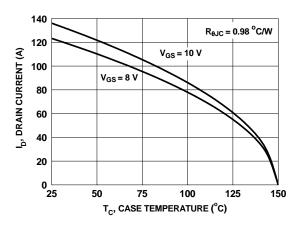


Figure 10. Maximum Continuous Drain Current vs Case Temperature

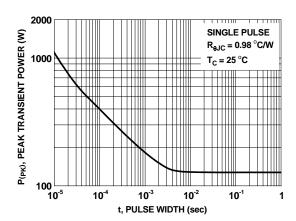


Figure 12. Single Pulse Maximum Power Dissipation

Typical Characteristics $T_J = 25$ °C unless otherwise noted

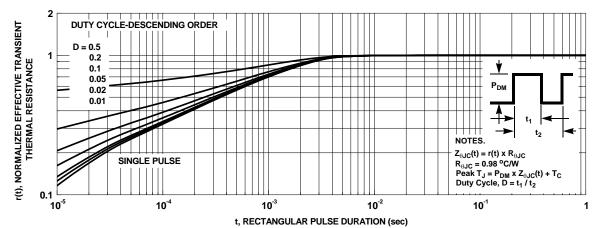


Figure 13. Junction-to-Case Transient Thermal Response Curve



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